

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	0	(color or colour or RGB or multicolor)same image\$1 same inspection near3(wafer\$1 or semiconductor\$1 or chip\$1 or PCB or printed adj circuit adj board or PWB or printed adj wiring adj board)same material near3 classificat\$2	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/05 10:42
L2	0	(color or colour or RGB or multicolor)same image\$1 same inspection near3(wafer\$1 or semiconductor\$1 or chip\$1 or PCB or printed adj circuit adj board or PWB or printed adj wiring adj board)and material near3 classificat\$2	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/05 10:46
L3	707	(color or colour or RGB or multicolor)and inspection near3(wafer\$1 or semiconductor\$1 or chip\$1 or PCB or printed adj circuit adj board or PWB or printed adj wiring adj board)and(BGA or ball adj grid adj array or conductor or laminat\$3 or lead or FPD or flat adj panel adj display)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/05 10:49
L4	543	(color or colour or RGB or multicolor)and inspection near3(wafer\$1 or semiconductor\$1 or chip\$1 or PCB or printed adj circuit adj board or PWB or printed adj wiring adj board)and(BGA or ball adj grid adj array or conductor or laminat\$3 or lead or FPD or flat adj panel adj display)and(plurality or plural)and(regions or areas)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/05 10:50
L5	75	4 and (edge\$1 or border\$1 or bounder\$1 or contour\$1)and mapp\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/05 10:52
L6	0	5 and identify\$3 near3 materials same (plurality or plural\$1)same(area or region)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/05 10:54
L7	6	5 and identify\$3 near3(plurality or plural\$1)same(area or region)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/05 10:54

L8	1	7 and @ad<"20000723"	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2005/07/05 10:55
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